Microwave Experiment: Week 2 **AP 4018 Columbia University**

Measure the wavelength of microwaves in a rectangular waveguide

Objective





Rectangular Waveguide

WR90 Specifications

- Recommended Frequency Band: 8.20 to 12.40 GHz
- Cutoff Frequency of Lowest Order Mode:
 6.557 GHz
- Cutoff Frequency of Upper Mode: 13.114 GHz
- Dimension:
 0.9 Inches [22.86 mm] x 0.4 Inches [10.16 mm]





Rectangular Waveguide: Various Components



Crystal Mount DB-453



Rotating Joint DB-446





90° Elbow (H Plane) DB-433





Uni-directional Broad Band Coupler DB-442



Bulkhead Flange DB-451



Uni-directional Narrow Band Coupler DB-440



Bi-directional Narrow Band Coupler DB-441





Mitered Elbow (H Plane) DB-439



90° Twist DB-435



RF Rodor Assembly D8-412

Matched Load

https://en.wikipedia.org/wiki/Waveguide_(radio_frequency)



 $\frac{\omega^2}{c^2} = k_x^2 + k_y^2 + k_z^2$



Dispersion Relation



 $k_y = 0$ and $k_x = -\pi$ (why?) \mathcal{O}



Total reflection makes an interference pattern in the waveguide (that is easy to detect!)





Slotted Line (Vernier Scale)

What is the Dispersion Relation? $\frac{\omega^2}{c^2} = k_x^2 + k_y^2 + k_z^2$ THE DISPERSION RELATION REFEAS TO THE RELATION SHIP BETWEEN THE WAVELENGTH OF THE LIGHT FRADITS FREQUENCY. FOR THIS LAB, WE DEAL ONLY WITH THE WAVELENGTH ALONG THE AXIS OF THE LAVE QUIDE.



Procedure - Week 2

PROCEDURE: FIRST, SHORT THE END OF Two maximum or minimum.



SECONDLY, USING THE TECHNIQUES YOU LEARNED LAST WEEK, ADJUST THE MICROWAUE FREQUENCY. (FOR EXAMPLE, (HANGE THE REFLECTOR VOLTAGE.) REPEAT YOUR MEASUREMENT OF THE WAVELENGTH. PLOT WAVELENGTH US. FREQUENCY AND COMPARE WITH FORMULA PROVIDED IN NOTES.

THE "SLOTTED LINE" WITH ALUMINUM FOIL (OR ANY 9000 CONDUCTOR). THEN, MOUE THE DETECTOR ALONG THE SLUTTED LINE TO RECORD THE DISTANCE BETWEEN



Reflection Coefficient

THE REFLECTION COEFFICIENT DETERMIN THE STANDING MALE PATTERN DET IN YOUR SCOTTED MANEQUIDE. IF THERE IS NO REFLECTION (A MATIC LOAD), THEN THERE IS NO STAN WAVE PATTERN. IF THERE IS TOT REFLECTION, THE DETECTOR SIGNAL M BY 100%. THE REFLECTION COEFF. MAS A MAGRATIO E AND A PHASE. T PHASE DETERMINES WHERE THE MAX+ MIN TO DETERMINE THE REFLECTION CUEF YOU MUST MEASURE THE STANDING WI PATTERN WITH THE SLUTTED LINE.

For these experiments, we only used A What is the reflection coefficient, $\Gamma =$

$$\frac{EQUATIONS}{E_{I}} = FORWARD FLECTRIC FIELD$$

$$\frac{E_{I}}{E_{I}} = FORWARD FLECTRIC FIELD = \Gamma E_{I}$$

$$\frac{E_{I}}{E_{I}} = \frac{1}{REFLECTED} = ELECTRIC FIELD = \Gamma E_{I}$$

$$\frac{E_{I}}{E_{I}} = \frac{1}{REFLECTED} = COEFFICIENT (Complex NU)$$

$$\frac{E_{I}}{D_{I}} = \frac{1}{REFLECTION} COEFFICIENT (Complex NU)$$

$$\frac{E_{I}}{D_{I}} = \frac{1}{E_{I}} (e^{ikt} + \Gamma e^{-ikt})$$

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$$\frac{E_{I}}{D_{I}} = \frac{1}{E_{I}} |1 + \Gamma e^{-ikt}|$$

$$\frac{E_{I}}{E_{I}} = \frac{1 + |\Gamma|}{1 - |\Gamma|} (LHERE \Gamma = |\Gamma|/2)$$

$$\frac{E_{I}}{E_{I}} = \frac{1 + |\Gamma|}{1 - |\Gamma|}$$



Summary and Question

- 9.514 GHz
- (*i.e.* $V_{det} \propto E^2$) measured with slotted line.
- What is the wavelength?
- Compare with expected dispersion relation.

• Measure: three frequencies: (for example) 9.419 GHz, 9.243 GHz, and

• Record: the positions of the *Minimum* and *Maximum* electric field intensity

- Compare wavelength to expected dispersion relationship



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